U.S. Patent Application Serial No. 10/574,277

Amendment filed September 9, 2009

Reply to OA dated June 9, 2009

AMENDMENTS TO THE CLAIMS:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

Claims 1-4: (Canceled)

Claim 5 (Currently Amended): A process for manufacturing a lithium tantalate substrate

by using a lithium tantalate crystal grown by the Czochralski method, wherein;

a lithium tantalate crystal grown by the Czochralski method and worked in the state of a substrate

is buried in a mixed powder of 25% by weight of Al and 75 % by weight of Al₂O₃, followed by heat

treatment carried out at a temperature kept to from kept from 350 to 600°C for 20 hours in an atmosphere

of nitrogen gas and under reduced pressure, to manufacture a lithium tantalate substrate having volume

resistivity which has been controlled within the range of from 10^{10} to 10^{13} Ω cm.

Claim 6: (Currently Amended): A process for manufacturing a lithium tantalate substrate by

using a lithium tantalate crystal grown by the Czochralski method, wherein;

a lithium tantalate crystal grown by the Czochralski method and worked in the state of a substrate

is buried in a mixed powder of 10% by weight of Al and 90 % by weight of Al₂O₃, followed by heat

treatment carried out at a temperature kept to from kept from 350 to 600°C for 20 hours in an atmosphere

of nitrogen gas and under reduced pressure, to manufacture a lithium tantalate substrate having volume

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resistivity which has been controlled within the range of from 10^{10} to 10^{13} Ω cm.

Claim 7 (Currently Amended): A process for manufacturing a lithium tantalate substrate by using

a lithium tantalate crystal grown by the Czochralski method, wherein;

a lithium tantalate crystal grown by the Czochralski method and worked in the state of a substrate

is buried in a mixed powder of 50% by weight of Al and 50 % by weight of Al₂O₃, followed by heat

treatment carried out at a temperature kept to from of 550°C for 40 hours in an atmosphere of nitrogen

gas and under atmospheric pressure, to manufacture a lithium tantalate substrate having volume resistivity

which has been controlled within the range of from 10^{10} to 10^{13} Ω cm.

Claim 8 (Currently Amended): A process for manufacturing a lithium tantalate substrate by using

a lithium tantalate crystal grown by the Czochralski method, wherein;

a lithium tantalate crystal grown by the Czochralski method and worked in the state of a substrate

is buried in a mixed powder of 25% by weight of Al and 75 % by weight of Al₂O₃, followed by heat

treatment carried out at a temperature kept to from of 550°C for 10 hours in an atmosphere of vacuum,

to manufacture a lithium tantalate substrate having volume resistivity which has been controlled within the

range of from 10^{10} to 10^{13} Ω cm.

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